Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/630,683	CHEN, YI-CHEN	
Examiner	Art Unit	
Navneet Sonia Khaira	3754	

			
	SEAR	CHED	
Class	Subclass	Date	Examiner
222	129,181.1, 153.01	4/4/2005	NK
222	153.03	4/4/2005	NK
222	160,173	4/4/2005	NK
222	493	4/4/2005	NK

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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	DATE	EXMR
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